



## N+P-Channel Enhancement MOSFET

### Description

The AP4G03MI6 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

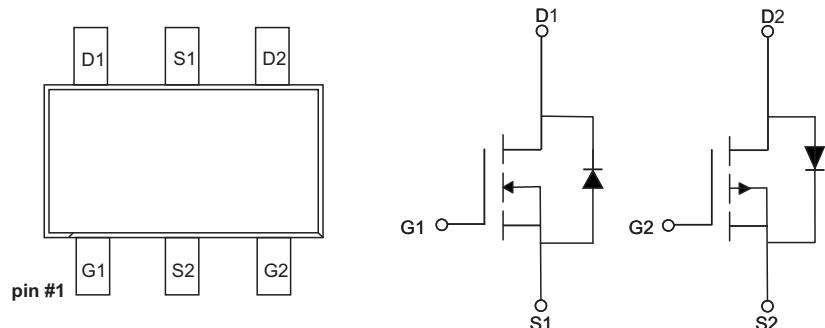
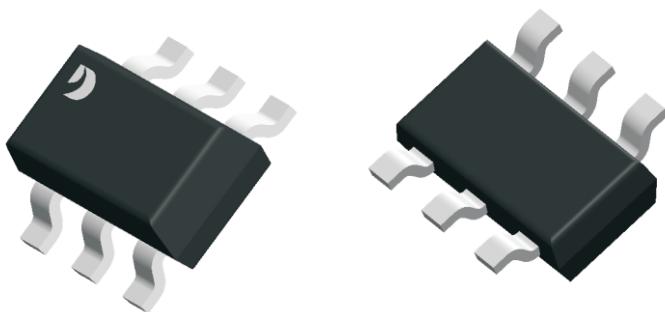
### General Features

$V_{DS}=30V, I_D=5.5A$   
 $R_{DS(ON)}<32m\Omega @ V_{GS}=10V$   
 $V_{DS}=-30V, I_D=4.0A$   
 $R_{DS(ON)}<45m\Omega @ V_{GS}=10V$

### Application

Battery protection  
Load Switch  
Uninterruptible power supply

SOT-26



### Absolute Maximum Ratings ( $T_c=25^\circ C$ , unless otherwise specified)

Parameter	Symbols	N-channel	P-channel	Units
Drain-Source Voltage	$V_{DSS}$	30	-30	V
Gate-Source Voltage	$V_{GSS}$	$\pm 12$	$\pm 12$	V
Continuous Drain Current	$I_D$	5.0	-3.5	A
Pulsed Drain Current	$I_{DM}$	30	-30	A
Continuous Source-Drain Current(Diode Conduction)	$I_S$	2.5	-1.7	A
Power Dissipation	$P_D$	1.15	1.15	W
Thermal Resistance from Junction to Ambient ( $t \leq 10s$ )	$R_{\theta JA}$	125	125	$^\circ C/W$
Operation Junction Temperature and Storage Temperature	$T_j, T_{stg}$	-55~+150	-55~+150	$^\circ C$



N-Channel Electrical Characteristics ( $T_J=25^\circ C$ , unless otherwise noted )

Parameter	Symbols	Test conditions	Min	Typ	Max	Units
Drain-Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	30			V
Gate -Source threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.6		1.4	V
Gate -Body leakage current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 100$	nA
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=30V, V_{GS}=0V$			1	$\mu A$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=3.4A$		28	32	$m\Omega$
		$V_{GS}=4.5V, I_D=3A$		32	38	$m\Omega$
		$V_{GS}=2.5V, I_D=2.8A$		39	50	$m\Omega$
Forward transconductancea	$g_{fs}$	$V_{DS}=5V, I_D=5A$		8		S
Diode forward voltage	$V_{SD}$	$I_S=1A, V_{GS}=0V$		0.8	1.3	V
Maximum Body-Diode Continuous current	$I_S$				2.5	A
Input Capacitance	$C_{iss}$	$V_{DS}=15V$ $V_{GS}=0V$ $f=1MHz$		390		pF
Output Capacitance	$C_{oss}$			54.5		pF
Reverse Transfer Capacitance	$C_{rss}$			41		pF
Total Gate Charge	$Q_g$	$V_{DS}=15V$ $V_{GS}=10V$ $I_D=4A$		4.5		nC
Gate-Source Charge	$Q_{gs}$			1.4		nC
Gate-Drain Charge	$Q_{gd}$			0.6		nC
Gate resistance	$R_g$	$f=1MHz$		3		$\Omega$
Turn-On delay time	$t_{d(on)}$	$V_{DS}=15V$ $R_L=5\Omega$ $I_D=4A$ $V_{GS}=10V$ $R_g=6\Omega$		4		ns
Rise Time	$t_r$			2		ns
Turn-Off delay time	$t_{d(off)}$			22		ns
Fall Time	$t_f$			3		ns
Body Diode Reverse Recovery Time	$T_{rr}$	$IF=4A, dI/dt=100A/\mu s$		11		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$IF=4A, dI/dt=100A/\mu s$		5.5		nC

Notes:

1. Repetitive Rating:Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t<10$  sec.
3. Pulse Test:Pulse Width $\leq 300\mu s$ , Duty Cycle $\leq 2\%$ .
4. Guaranteed by design, not subject to production testing



P-Channel Electrical Characteristics ( $T_J=25^\circ C$ , unless otherwise noted)

Parameter	Symbols	Test conditions	Min	Typ	Max	Units
Drain-Source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-30			V
Gate -Source threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.6		-1.4	V
Gate -Body leakage current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 100$	nA
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=-24V, V_{GS}=0V$			-1	$\mu A$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-2.5A$		40	45	$m\Omega$
		$V_{GS}=-4.5V, I_D=-2A$		45	50	$m\Omega$
		$V_{GS}=-2.5V, I_D=1A$		50	70	$m\Omega$
Forward transconductancea	$g_{fs}$	$V_{DS}=-5V, I_D=-4A$		8		S
Diode forward voltage	$V_{SD}$	$I_S=-1A, V_{GS}=0V$		-0.8	-1.2	V
Maximum Body-Diode Continuous current	$I_S$				-1.7	A
Input Capacitance	$C_{iss}$	$V_{DS}=-15V$ $V_{GS}=0V$ $f=1MHz$		409		pF
Output Capacitance	$C_{oss}$			55		pF
Reverse Transfer Capacitance	$C_{rss}$			42		pF
Total Gate Charge	$Q_g$	$V_{DS}=-15V$ $V_{GS}=-10V$ $I_D=-4A$		4.8		nC
Gate-Source Charge	$Q_{gs}$			1.4		nC
Gate-Drain Charge	$Q_{gd}$			0.72		nC
Gate resistance	$R_g$	$f=1MHz$		12		$\Omega$
Turn-On delay time	$t_{d(on)}$	$V_{DS}=-15V$ $R_L=4.4\Omega$ $I_D=-4A$ $V_{GS}=-10V$ $R_g=3\Omega$		13		ns
Rise Time	$t_r$			10		ns
Turn-Off delay time	$t_{d(off)}$			28		ns
Fall Time	$t_f$			13		ns
Body Diode Reverse Recovery Time	$T_{rr}$	$IF=-4A, dI/dt=100A/\mu s$		26		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$IF=-4A, dI/dt=100A/\mu s$		15.6		nC

Notes:

1. Repetitive Rating:Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t<10$  sec.
3. Pulse Test:Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production testing



## N Channel Typical Characteristics

Figure1: Typical Output Characteristics

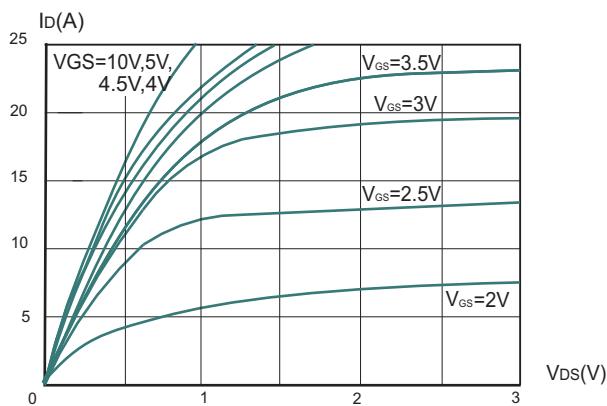


Figure3: Typical Transfer Characteristics

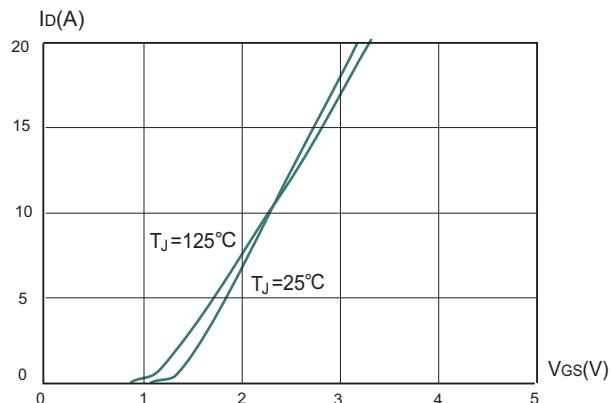


Figure5 : Typical Source-Drain Diode Forward Voltage

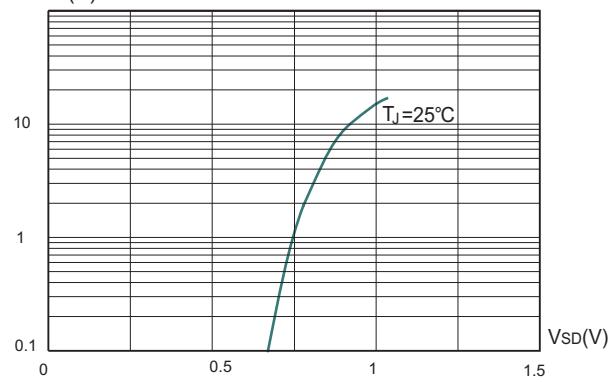


Figure 2: Normalized Threshold Voltage vs. Temperature

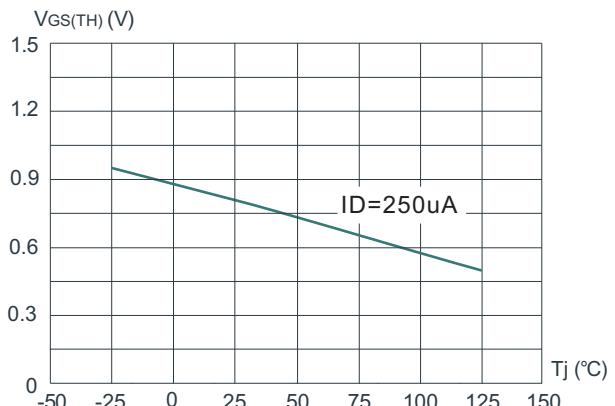


Figure 4: On-resistance vs. Drain Current and Gate

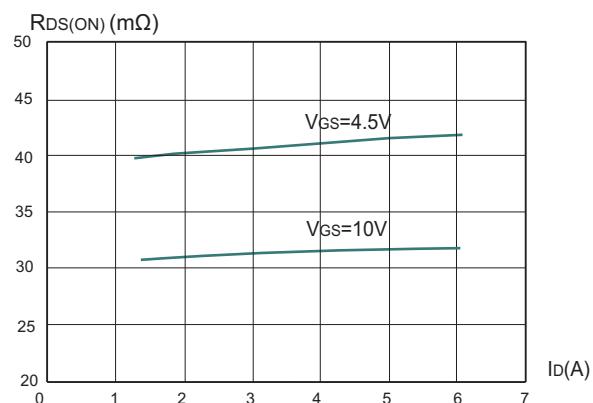
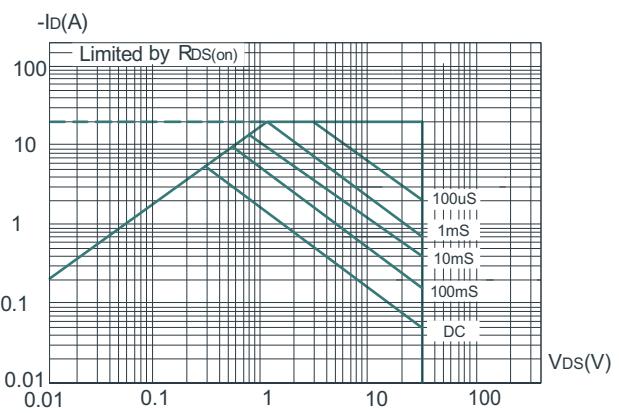


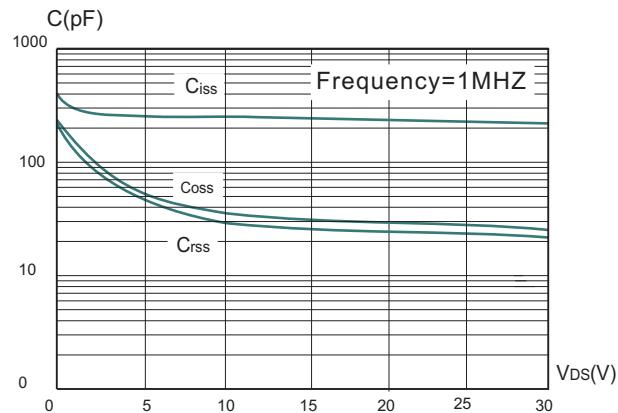
Figure 6: Maximum Safe Operating Area



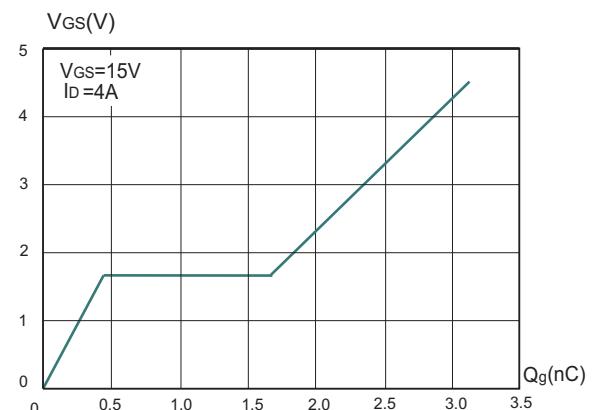


## N Channel Typical Characteristics

**Figure 7:** Typical Capacitance Vs.  
Drain-Source Voltage



**Figure 8:** Typical Gate Charge Vs.  
Gate-Source Voltage





## P Channel Typical Characteristics

Figure9: Typical Output Characteristics

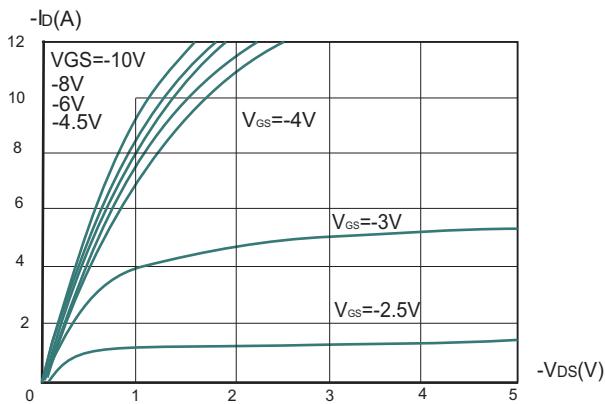


Figure11:Typical Transfer Characteristics

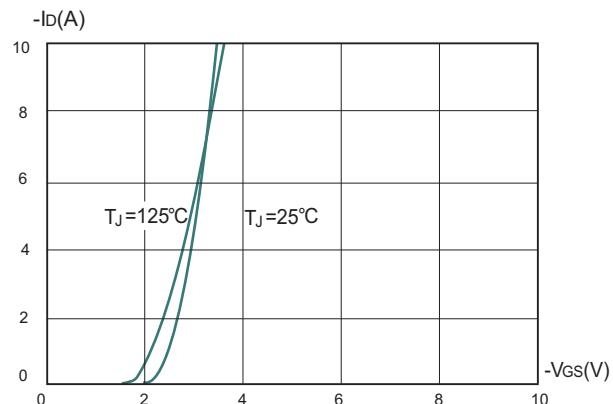


Figure13:Typical Source-Drain Diode Forward Voltage

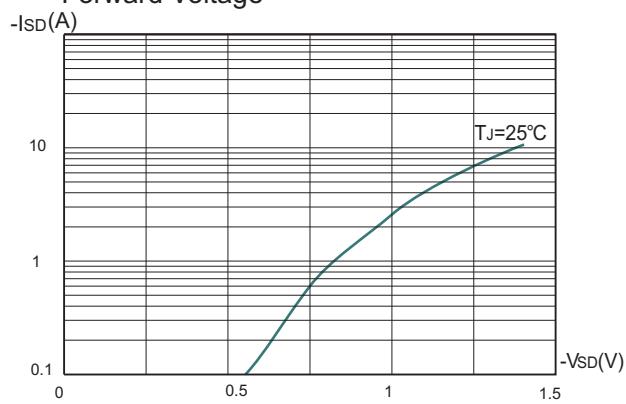


Figure10: Normalized Threshold Voltage vs. Temperature

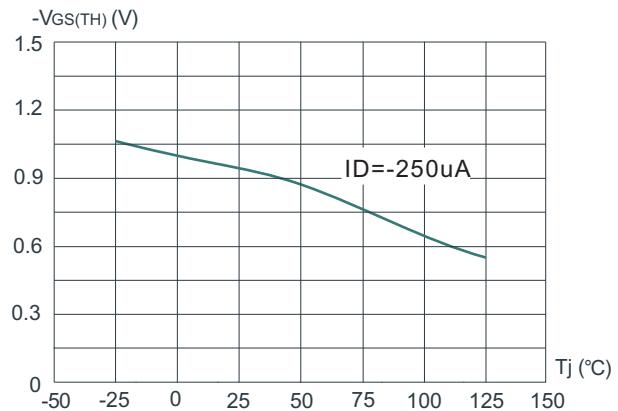


Figure12:On-resistance vs. Drain Current and Gate

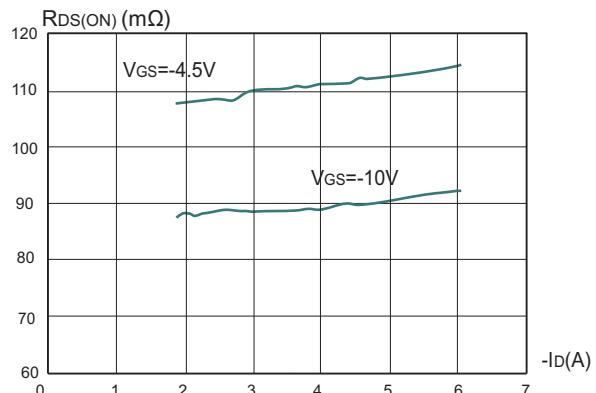
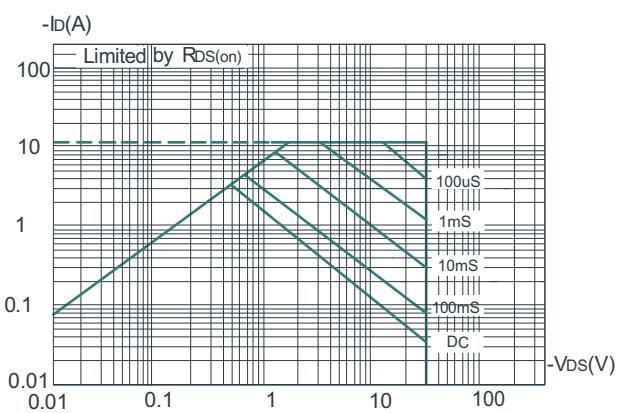


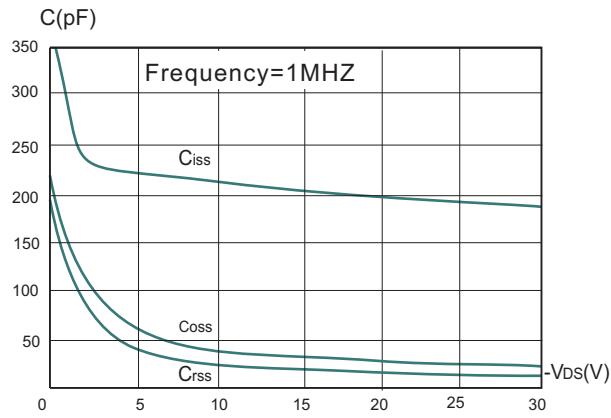
Figure14: Maximum Safe Operating Area



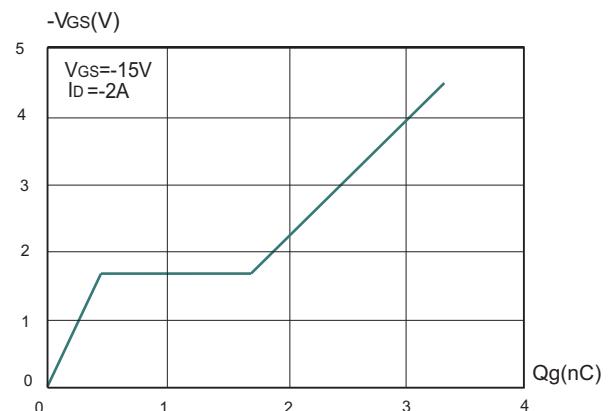


## P Channel Typical Characteristics

**Figure15:** Typical Capacitance Vs. Drain-Source Voltage

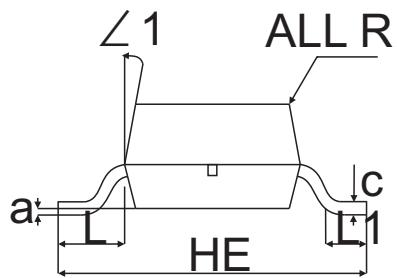
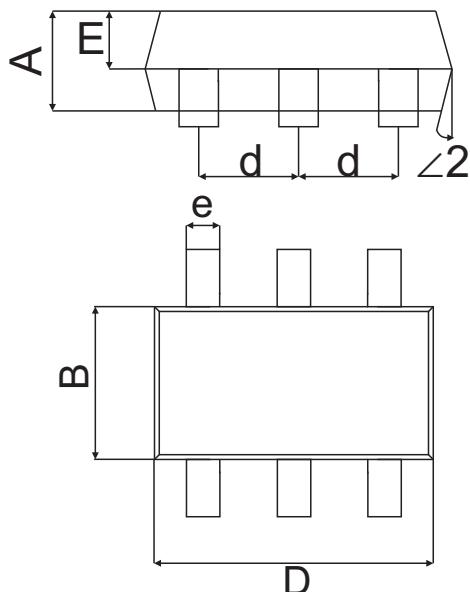


**Figure16:** Typical Gate Charge Vs.Gate-Source Voltage



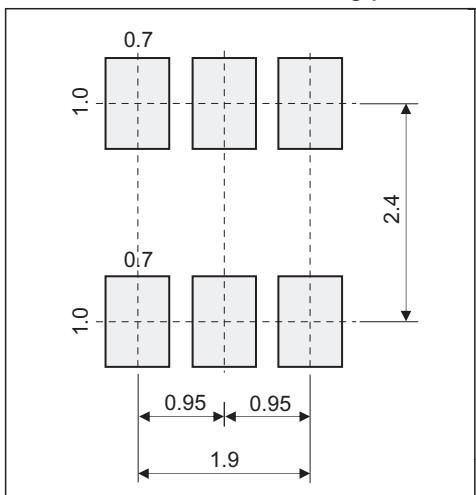


## SOT-26 Package Outline Dimensions



Unit		A	B	C	HE	D	d	E	e	L	L1	a	R	∠1	∠2
mm	max	1.05	1.80	0.20	2.90	3.12	1.00	0.65	0.40	0.70	0.60	0.2 (ref)	R0.1 (ref)	12°	10°
	typ	0.95	1.60	0.15	2.80	2.92	0.95	0.55	0.35	0.60	/				
	min	0.85	1.40	0.10	2.70	2.72	0.90	0.45	0.30	0.50	0.20				
mil	max	41	71	8	114	123	39	26	16	28	24	8 (ref)	R4 (ref)		
	typ	37	63	6	110	115	37	22	14	24	/				
	min	33	55	4	106	107	35	18	12	20	8				

The recommended mounting pad size



Marking

Type number	Marking code
NPM3400	3400